

**Search Notes**

Application/Control No.

10/715,198

Examiner

C. SAYALA

Applicant(s)/Patent under  
Reexamination

LEE ET AL.

Art Unit

1761

**SEARCHED**

Class	Subclass	Date	Examiner
426	656	2/16/2007	CS
	657		
	658		
	641		
	549		
	805		
	650		
	302		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
426	656, 657	2/16/2007	CS
	658, 641	2/16/2007	C/S
	650, 549		
426/805, 302			

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
search appended	2/16/2007	CS